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APPLICANTSTadashi Mitsui, Kanagawa, JAPAN; *DPR***** CONTINUING DATA ********DPR***** FOREIGN APPLICATIONS *******JAPAN 2003-83324 03/25/2003 *DPR***IF REQUIRED, FOREIGN FILING LICENSE GRANTED**

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Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	STATE OR COUNTRY JAPAN	SHEETS DRAWING 7	TOTAL CLAIMS 20	INDEPENDENT CLAIMS 6
35 USC 119 (a-d) conditions <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after met <i>DPR</i>				
Verified and Acknowledged <i>DPR</i> Examiner's Signature	Initials <i>DPR</i>			

ADDRESS

22852

TITLE

Pattern measuring apparatus, pattern measuring method, and manufacturing method of semiconductor device

FILING FEE RECEIVED 1158	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit
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